

Based on Form PTO-1449 (3/90)	ATTY. DOCKET NO. 450110-05324	SERIAL NO. Filed Concurrently Herewith
LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)	APPLICANT Robert Mark Stefan PORTER et al.	
	FILING DATE Filed Concurrently Herewith	GROUP

U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
/S.H./	AA	2001/0043727	11/22/01	Cooper			
	AB						
	AC						
	AD						
	AE						
	AF						

FOREIGN PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
/S.H./	AG	JP 2001-167110	06/22/01	Japan			
/S.H./	AH	JP 2002-27411	01/25/02	Japan			
/S.H./	AI	WO 00/16243	03/23/00	PCT			
/S.H./	AJ	WO 99/51022	10/07/99	PCT			
	AK						

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)			
/S.H./	AL		Patent Abstracts of Japan, Publication No. 06086295, Publication Date March 25, 1994
/S.H./	AM		Patent Abstracts of Japan, Publication No. 2003204541, Publication Date July 18, 2003
/S.H./	AN		H. Schneiderman and T. Kanade, "A statistical model for 3D object detection applied to faces and cars," IEEE Conference on Computer Vision and Pattern Detection, 2000.
/S.H./	AO		H. Schneiderman and T. Kanade, "Probabilistic modelling of local appearance and spatial relationships for object detection," IEEE Conference on Computer Vision and Pattern Detection, 1998.
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/S.H./	AQ		E. Hjelm and B.K. Low, "Face Detection: A Survey," Computer Vision and Image Understanding, no. 83, pp. 236-274, 2001
/S.H./	AR		M.-H. Yang, D. Kriegman and N. Ahuja, "Detecting Faces in Images: A Survey," IEEE Trans. on Pattern Analysis and Machine Intelligence, vol. 24, no. 1, pp. 34-58, Jan 2002

EXAMINER  /Sara Hanne/	DATE CONSIDERED  (12/04/2007)
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